


<b>Search Notes</b>  	<b>Application/Control No.</b>  10532071	<b>Applicant(s)/Patent Under Reexamination</b>  BONNE ET AL.
	<b>Examiner</b>  KEVIN L LEE	<b>Art Unit</b>  3753

SEARCHED			
Class	Subclass	Date	Examiner
137	513.3, 513.5, 843, 528, 535, 540, 517	8/27/2008	KL

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

--	--